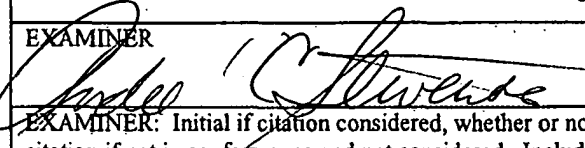
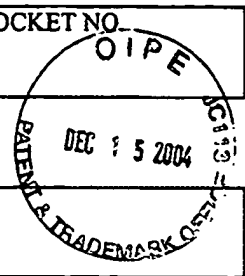


FORM PTO-1449		US Dept. of Commerce Patent and Trademark Office		ATTORNEY DOCKET NO. ATMI-567-DIV		SERIAL NO. TBA	
INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)				APPLICANT Jose Arno			
				FILING DATE Herewith		GROUP TBA	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	PATENT NUMBER	ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUBCLAS S	TRANSLATION YES. NO	
						X (abstract only)	
OTHER DOCUMENTS (Including Author, Title, Journal-Date, Page Number, Etc.)							
AA	Application Note of Thermopile IR Sensors, (Rev.02), Thermometrics Global Business, pgs. 1-9, and attachment pages, September 1999.						
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

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	APPLICANT Jose I. Arno		2812
	FILING DATE July 18, 2003		
	GROUP		



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